# 74LVC1G34

Single buffer
Rev. 5 — 2 July 2012

**Product data sheet** 

#### **General description** 1.

The 74LVC1G34 provides a low-power, low-voltage single buffer.

The input can be driven from either 3.3 V or 5 V devices. This feature allows the use of this device in a mixed 3.3 V and 5 V environment.

This device is fully specified for partial power-down applications using I<sub>OFF</sub>. The I<sub>OFF</sub> circuitry disables the output, preventing the damaging backflow current through the device when it is powered down.

Schmitt trigger action at all inputs makes the circuit highly tolerant of slower input rise and fall times.

#### **Features and benefits** 2.

- Wide supply voltage range from 1.65 V to 5.5 V
- 5 V tolerant inputs for interfacing with 5 V logic
- High noise immunity
- Complies with JEDEC standard:
  - ◆ JESD8-7 (1.65 V to 1.95 V)
  - ◆ JESD8-5 (2.3 V to 2.7 V)
  - ◆ JESD8-B/JESD36 (2.7 V to 3.6 V).
- ESD protection:
  - HBM JESD22-A114F exceeds 2000 V
  - MM JESD22-A115-A exceeds 200 V
- $\pm$  24 mA output drive (V<sub>CC</sub> = 3.0 V)
- CMOS low power consumption
- Latch-up performance exceeds 250 mA
- Direct interface with TTL levels
- Inputs accept voltages up to 5 V
- Multiple package options
- Specified from -40 °C to +85 °C and -40 °C to +125 °C



### 3. Ordering information

Table 1. Ordering information

Type number	Package							
	Temperature range Name		Description	Version				
74LVC1G34GW	–40 °C to +125 °C	TSSOP5	plastic thin shrink small outline package; 5 leads; body width 1.25 mm	SOT353-1				
74LVC1G34GV	–40 °C to +125 °C	SC-74A	plastic surface-mounted package; 5 leads	SOT753				
74LVC1G34GM	–40 °C to +125 °C	XSON6	plastic extremely thin small outline package; no leads; 6 terminals; body 1 $\times$ 1.45 $\times$ 0.5 mm	SOT886				
74LVC1G34GF	–40 °C to +125 °C	XSON6	plastic extremely thin small outline package; no leads; 6 terminals; body 1 $\times$ 1 $\times$ 0.5 mm	SOT891				
74LVC1G34GN	–40 °C to +125 °C	XSON6	extremely thin small outline package; no leads; 6 terminals; body $0.9 \times 1.0 \times 0.35$ mm	SOT1115				
74LVC1G34GS	–40 °C to +125 °C	XSON6	extremely thin small outline package; no leads; 6 terminals; body 1.0 $\times$ 1.0 $\times$ 0.35 mm	SOT1202				
74LVC1G34GX	–40 °C to +125 °C	X2SON5	X2SON5: plastic thermal enhanced extremely thin small outline package; no leads; 5 terminals; body $0.8 \times 0.8 \times 0.35$ mm	SOT1226				

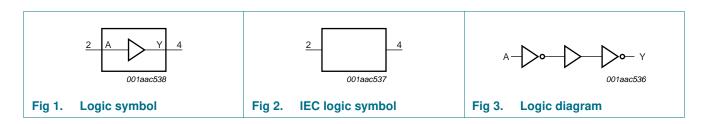
### 4. Marking

Table 2. Marking

Marking code <sup>[1]</sup>
YN

<sup>[1]</sup> The pin 1 indicator is located on the lower left corner of the device, below the marking code.

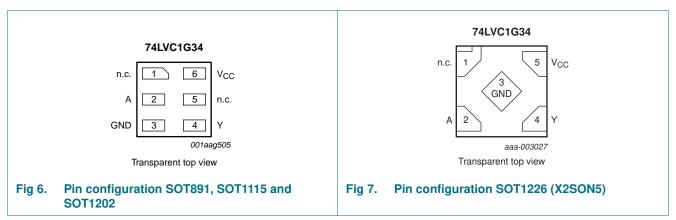
### 5. Functional diagram



### 6. Pinning information

#### 6.1 Pinning





### 6.2 Pin description

Table 3. Pin description

Symbol	Pin		Description
	TSSOP5 and X2SON5	XSON6	
n.c.	1	1	not connected
Α	2	2	data input
GND	3	3	ground (0 V)
Υ	4	4	data output
n.c.	-	5	not connected
$V_{CC}$	5	6	supply voltage

### 7. Functional description

Table 4. Function table[1]

Input	Output
Α	Υ
L	L
H	Н

<sup>[1]</sup> H = HIGH voltage level;

### 8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CC}$	supply voltage		-0.5	+6.5	V
I <sub>IK</sub>	input clamping current	V <sub>I</sub> < 0 V	-50	-	mA
VI	input voltage		<u>[1]</u> –0.5	+6.5	V
I <sub>OK</sub>	output clamping current	$V_O > V_{CC}$ or $V_O < 0$ V	-	±50	mA
V <sub>O</sub>	output voltage	Active mode	[1][2] -0.5	$V_{CC} + 0.5$	V
		Power-down mode	[1][2] -0.5	+6.5	V
I <sub>O</sub>	output current	$V_O = 0 V to V_{CC}$	-	±50	mA
I <sub>CC</sub>	supply current		-	100	mA
I <sub>GND</sub>	ground current		-100	-	mA
P <sub>tot</sub>	total power dissipation	$T_{amb} = -40  ^{\circ}\text{C} \text{ to } +125  ^{\circ}\text{C}$	<u>[3]</u> _	250	mW
T <sub>stg</sub>	storage temperature		-65	+150	°C

<sup>[1]</sup> The minimum input and output voltage ratings may be exceeded if the input and output current ratings are observed.

### 9. Recommended operating conditions

Table 6. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{CC}$	supply voltage		1.65	-	5.5	V
VI	input voltage		0	-	5.5	V
Vo	output voltage	Active mode	0	-	$V_{CC}$	$V_{O}$
		V <sub>CC</sub> = 0 V; Power-down mode	0	-	5.5	Vo
T <sub>amb</sub>	ambient temperature		-40	-	+125	°C
$\Delta t/\Delta V$	input transition rise and fall rate	V <sub>CC</sub> = 1.65 V to 2.7 V	-	-	20	ns/V
		$V_{CC} = 2.7 \text{ V to } 5.5 \text{ V}$	-	-	10	ns/V

74LVC1G34

L = LOW voltage level.

<sup>[2]</sup> When  $V_{CC} = 0 \text{ V}$  (Power-down mode), the output voltage can be 5.5 V in normal operation.

<sup>[3]</sup> For TSSOP5 and SC-74A packages: above 87.5 °C the value of P<sub>tot</sub> derates linearly with 4.0 mW/K. For XSON6 and X2SON5 package: above 118 °C the value of P<sub>tot</sub> derates linearly with 7.8 mW/K.

### 10. Static characteristics

Table 7. Static characteristics

At recommended operating conditions. Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Uni
T <sub>amb</sub> = -	40 °C to +85 °C[1]					
V <sub>IH</sub>	HIGH-level input voltage	V <sub>CC</sub> = 1.65 V to 1.95 V	$0.65~\times V_{CC}$	-	-	٧
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.7	-	-	٧
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	2.0	-	-	٧
		V <sub>CC</sub> = 4.5 V to 5.5 V	$0.7 \times V_{CC}$	-	-	٧
V <sub>IL</sub>	LOW-level input voltage	V <sub>CC</sub> = 1.65 V to 1.95 V	-	-	$0.35 \times V_{CC}$	٧
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	-	-	0.7	٧
		V <sub>CC</sub> = 2.7 V to 3.6 V	-	-	0.8	٧
		V <sub>CC</sub> = 4.5 V to 5.5 V	-	-	$0.3~\times V_{CC}$	٧
V <sub>OH</sub>	HIGH-level output voltage	$V_I = V_{IH}$ or $V_{IL}$				
		$I_O = -100 \mu A$ ; $V_{CC} = 1.65 \text{ V to } 5.5 \text{ V}$	V <sub>CC</sub> - 0.1	-	-	٧
		$I_O = -4 \text{ mA}$ ; $V_{CC} = 1.65 \text{ V}$	1.2	1.54	-	٧
		$I_{O} = -8 \text{ mA}; V_{CC} = 2.3 \text{ V}$	1.9	2.15	-	٧
		$I_{O} = -12 \text{ mA}; V_{CC} = 2.7 \text{ V}$	2.2	2.50	-	٧
		$I_{O} = -24 \text{ mA}$ ; $V_{CC} = 3.0 \text{ V}$	2.3	2.62	-	٧
		$I_{O} = -32 \text{ mA}$ ; $V_{CC} = 4.5 \text{ V}$	3.8	4.11	-	٧
V <sub>OL</sub>	LOW-level output voltage	$V_I = V_{IH}$ or $V_{IL}$				
		$I_O = 100 \mu A$ ; $V_{CC} = 1.65 \text{ V to } 5.5 \text{ V}$	-	-	0.10	٧
		I <sub>O</sub> = 4 mA; V <sub>CC</sub> = 1.65 V	-	0.07	0.45	٧
		$I_{O} = 8 \text{ mA}; V_{CC} = 2.3 \text{ V}$	-	0.12	0.30	٧
		$I_O = 12 \text{ mA}; V_{CC} = 2.7 \text{ V}$	-	0.17	0.40	٧
		$I_O = 24 \text{ mA}; V_{CC} = 3.0 \text{ V}$	-	0.33	0.55	٧
		$I_O = 32 \text{ mA}; V_{CC} = 4.5 \text{ V}$	-	0.39	0.55	٧
l <sub>l</sub>	input leakage current	$V_{CC} = 0 \text{ V to } 5.5 \text{ V}; V_{I} = 5.5 \text{ V or GND}$	[2] _	±0.1	±5	μΑ
l <sub>OFF</sub>	power-off leakage current	$V_{CC} = 0 \text{ V}; V_{I} \text{ or } V_{O} = 5.5 \text{ V}$	-	±0.1	±10	μA
I <sub>CC</sub>	supply current	V <sub>CC</sub> = 1.65 V to 5.5 V; I <sub>O</sub> = 0 A; V <sub>I</sub> = 5.5 V or GND	-	0.1	10	μΑ
Δl <sub>CC</sub>	additional supply current	$V_{CC} = 2.3 \text{ V to } 5.5 \text{ V}; V_{I} = V_{CC} - 0.6 \text{ V};$ $I_{O} = 0 \text{ A}$	[2] -	5	500	μА
C <sub>I</sub>	input capacitance 40 °C to +125 °C	$V_{CC}$ = 3.3 V; $V_I$ = GND to $V_{CC}$	-	4	-	pF
V <sub>IH</sub>	HIGH-level input voltage	V <sub>CC</sub> = 1.65 V to 1.95 V	0.65 × V <sub>CC</sub>	_	-	V
- 111		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.7	_	_	V
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	2.0	_		V
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	0.7 × V <sub>CC</sub>	_		V
V <sub>IL</sub>	LOW-level input voltage	V <sub>CC</sub> = 4.65 V to 1.95 V	-	_	0.35 × V <sub>CC</sub>	V
• IL	2011 lovoi input voitage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$			0.33 × 100	V
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$ $V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	_		0.7	V
		$V_{CC} = 2.7 \text{ V to } 5.6 \text{ V}$ $V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$		_	0.8 × V <sub>CC</sub>	V
		A C.C. = 4.9 A 10 9.9 A	-	-	O'O × ACC	٧

 Table 7.
 Static characteristics ...continued

At recommended operating conditions. Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{OH}$	HIGH-level output voltage	$V_I = V_{IH}$ or $V_{IL}$				
		$I_O = -100~\mu A;~V_{CC} = 1.65~V$ to 5.5 $V$	$V_{CC}-0.1$	-	-	V
		$I_O = -4 \text{ mA}; V_{CC} = 1.65 \text{ V}$	0.95	-	-	V
		$I_{O} = -8 \text{ mA}; V_{CC} = 2.3 \text{ V}$	1.7	-	-	V
		$I_{O} = -12 \text{ mA}; V_{CC} = 2.7 \text{ V}$	1.9	-	-	V
		$I_{O} = -24 \text{ mA}; V_{CC} = 3.0 \text{ V}$	2.0	-	-	V
		$I_{O} = -32 \text{ mA}; V_{CC} = 4.5 \text{ V}$	3.4	-	-	V
$V_{OL}$	LOW-level output voltage	$V_I = V_{IH}$ or $V_{IL}$				
		$I_O = 100 \mu A$ ; $V_{CC} = 1.65 V$ to 5.5 V	-	-	0.10	V
		$I_O = 4 \text{ mA}; V_{CC} = 1.65 \text{ V}$	-	-	0.70	V
		$I_O = 8 \text{ mA}; V_{CC} = 2.3 \text{ V}$	-	-	0.45	V
		$I_O = 12 \text{ mA}; V_{CC} = 2.7 \text{ V}$	-	-	0.60	V
		$I_O = 24 \text{ mA}; V_{CC} = 3.0 \text{ V}$	-	-	0.80	V
		$I_O = 32 \text{ mA}; V_{CC} = 4.5 \text{ V}$	-	-	0.80	V
I <sub>I</sub>	input leakage current	$V_{CC} = 0 \text{ V to } 5.5 \text{ V}; V_I = 5.5 \text{ V or GND}$	-	-	±100	μΑ
I <sub>OFF</sub>	power-off leakage current	$V_{CC} = 0 \text{ V}; V_{I} \text{ or } V_{O} = 5.5 \text{ V}$	-	-	±200	μΑ
I <sub>CC</sub>	supply current	$V_{CC}$ = 1.65 V to 5.5 V; $I_{O}$ = 0 A; $V_{I}$ = 5.5 V or GND	-	-	200	μΑ
$\Delta I_{CC}$	additional supply current	$V_{CC}$ = 2.3 V to 5.5 V; $V_{I}$ = $V_{CC}$ - 0.6 V; $I_{O}$ = 0 A	-	-	5000	μΑ

<sup>[1]</sup> All typical values are measured at  $T_{amb}$  = 25 °C.

<sup>[2]</sup> These typical values are measured at  $V_{\text{CC}}$  = 3.3 V.

### 11. Dynamic characteristics

Table 8. Dynamic characteristics

Voltages are referenced to GND (ground = 0 V). For test circuit see Figure 9.

Symbol	Parameter	Conditions		-40 °C to +85 °C			-40 °C to	Unit	
				Min	Typ[1]	Max	Min	Max	
$t_{pd}$	propagation delay	A to Y; see Figure 8	[2]						
		V <sub>CC</sub> = 1.65 V to 1.95 V		1.0	4.0	8.6	1.0	11.0	ns
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		0.5	2.6	4.4	0.5	5.6	ns
		$V_{CC} = 2.7 \text{ V}$		0.5	2.3	4.5	0.5	5.6	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$		0.5	2.0	4.1	0.5	5.2	ns
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$		0.5	1.6	3.2	0.5	4.1	ns
$C_{PD}$	power dissipation capacitance	$V_I = GND \text{ to } V_{CC}; V_{CC} = 3.3 \text{ V}$	[3]	-	15	-	-	-	pF

<sup>[1]</sup> Typical values are measured at  $T_{amb} = 25$  °C and  $V_{CC} = 1.8$  V, 2.5 V, 2.7 V, 3.3 V, and 5.0 V respectively.

[3]  $C_{PD}$  is used to determine the dynamic power dissipation ( $P_D$  in  $\mu W$ ).

$$P_D = C_{PD} \times V_{CC}{}^2 \times f_i \times N + \sum (C_L \times V_{CC}{}^2 \times f_o)$$
 where:

 $f_i$  = input frequency in MHz;

f<sub>o</sub> = output frequency in MHz;

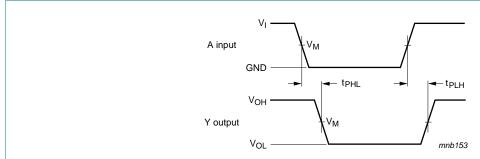
C<sub>L</sub> = output load capacitance in pF;

 $V_{CC}$  = supply voltage in V;

N = number of inputs switching;

 $\sum (C_L \times V_{CC}^2 \times f_o) = sum \text{ of outputs.}$ 

### 12. Waveforms



Measurement points are given in Table 9.

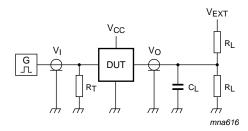
 $V_{\text{OL}}$  and  $V_{\text{OH}}$  are typical output voltage drops that occur with the output load.

Fig 8. The data input (A) to output (Y) propagation delays

<sup>[2]</sup>  $t_{pd}$  is the same as  $t_{PLH}$  and  $t_{PHL}$ .

Table 9. Measurement points

Supply voltage	Input	Output
V <sub>CC</sub>	V <sub>M</sub>	V <sub>M</sub>
1.65 V to 1.95 V	$0.5 \times V_{CC}$	$0.5 \times V_{CC}$
2.3 V to 2.7 V	$0.5 \times V_{CC}$	0.5 × V <sub>CC</sub>
2.7 V	1.5 V	1.5 V
3.0 V to 3.6 V	1.5 V	1.5 V
4.5 V to 5.5 V	0.5 × V <sub>CC</sub>	0.5 × V <sub>CC</sub>



Test data is given in Table 10.

Definitions for test circuit:

R<sub>L</sub> = Load resistance.

 $C_L$  = Load capacitance including jig and probe capacitance.

 $R_T$  = Termination resistance should be equal to the output impedance  $Z_0$  of the pulse generator.

 $V_{\text{EXT}}$  = External voltage for measuring switching times.

Fig 9. Test circuit for measuring switching times

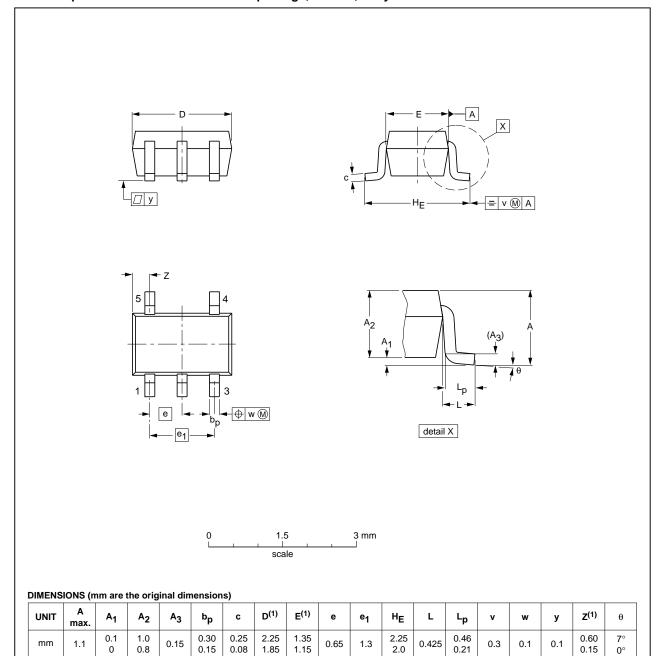
Table 10. Test data

Supply voltage	Input		Load	Load	
V <sub>CC</sub>	VI	$t_r = t_f$	CL	R <sub>L</sub>	t <sub>PLH</sub> , t <sub>PHL</sub>
1.65 V to 1.95 V	$V_{CC}$	≤ 2.0 ns	30 pF	1 kΩ	open
2.3 V to 2.7 V	V <sub>CC</sub>	≤ 2.0 ns	30 pF	500 Ω	open
2.7 V	2.7 V	≤ 2.5 ns	50 pF	500 Ω	open
3.0 V to 3.6 V	2.7 V	≤ 2.5 ns	50 pF	500 Ω	open
4.5 V to 5.5 V	$V_{CC}$	≤ 2.5 ns	50 pF	500 Ω	open

### 13. Package outline

TSSOP5: plastic thin shrink small outline package; 5 leads; body width 1.25 mm

SOT353-1



#### Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

	OUTLINE	REFERENCES				EUROPEAN	ISSUE DATE
VERSION	VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
	SOT353-1		MO-203	SC-88A			<del>-00-09-01</del> 03-02-19

Fig 10. Package outline SOT353-1 (TSSOP5)

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#### Plastic surface-mounted package; 5 leads

**SOT753** 

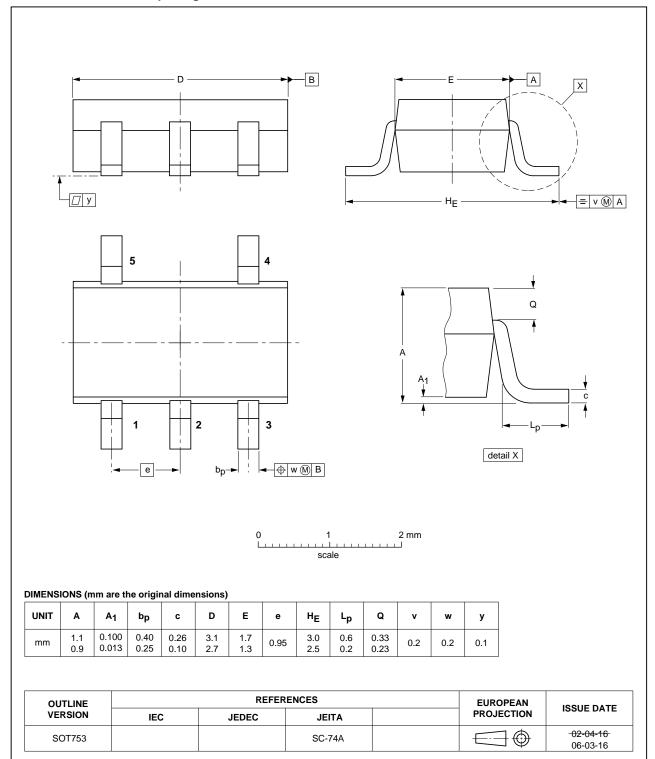


Fig 11. Package outline SOT753 (SC-74A)

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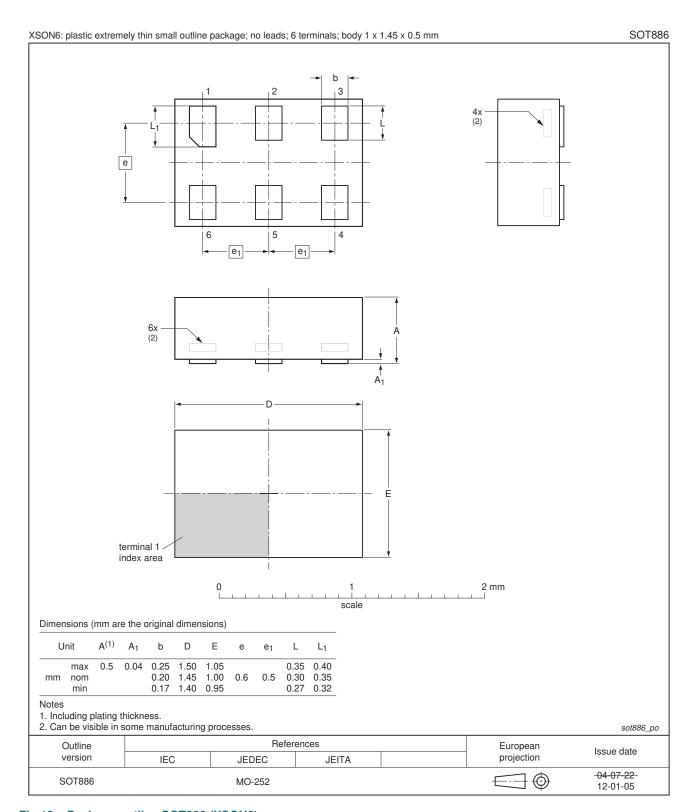


Fig 12. Package outline SOT886 (XSON6)

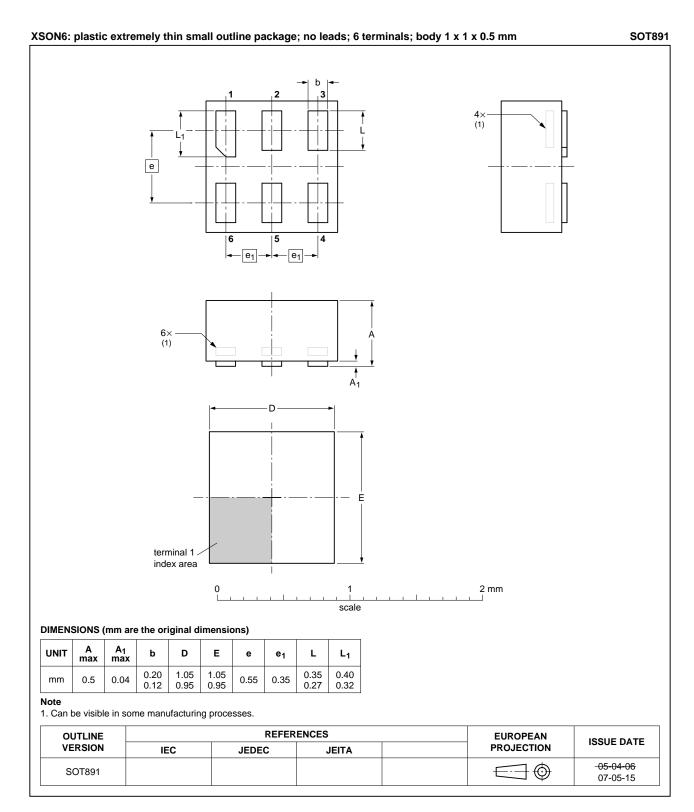


Fig 13. Package outline SOT891 (XSON6)

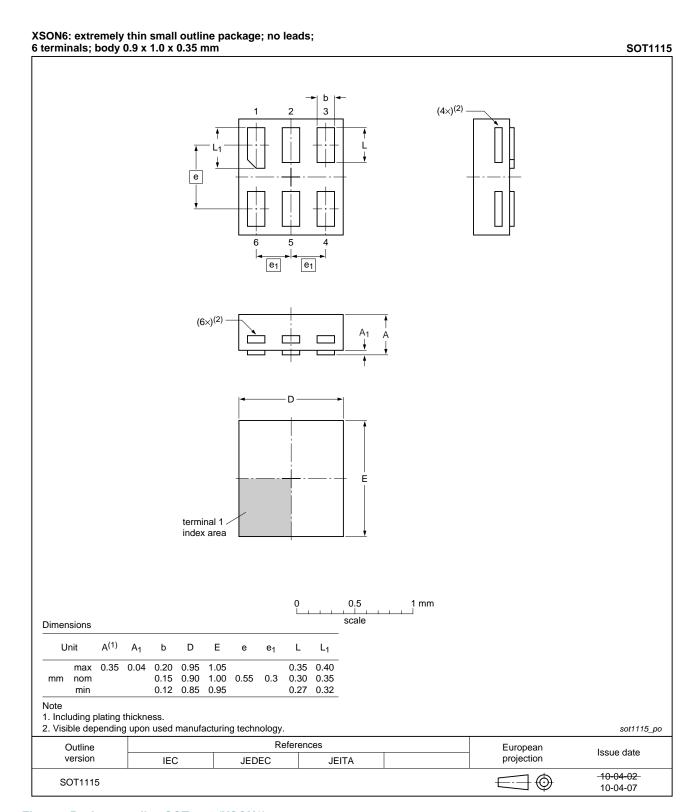


Fig 14. Package outline SOT1115 (XSON6)

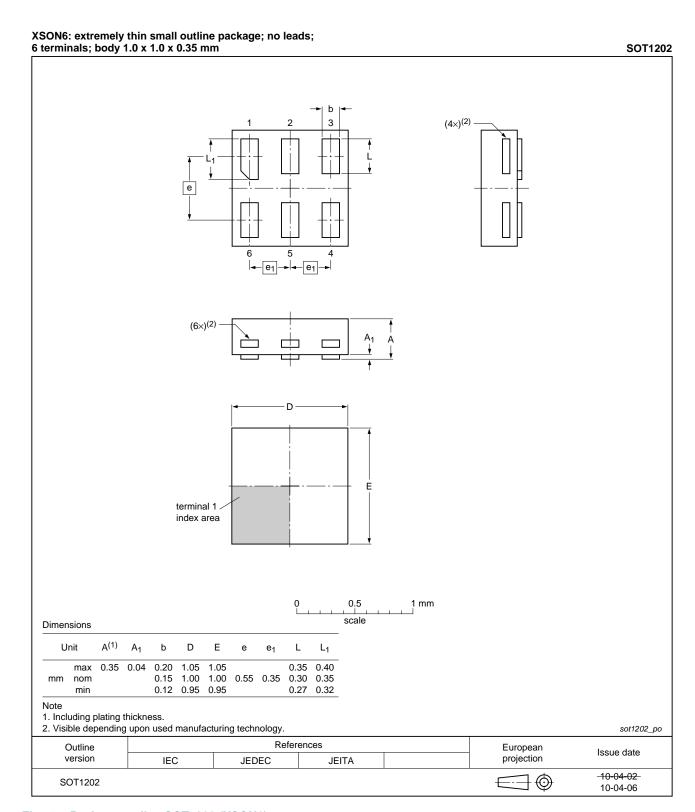


Fig 15. Package outline SOT1202 (XSON6)

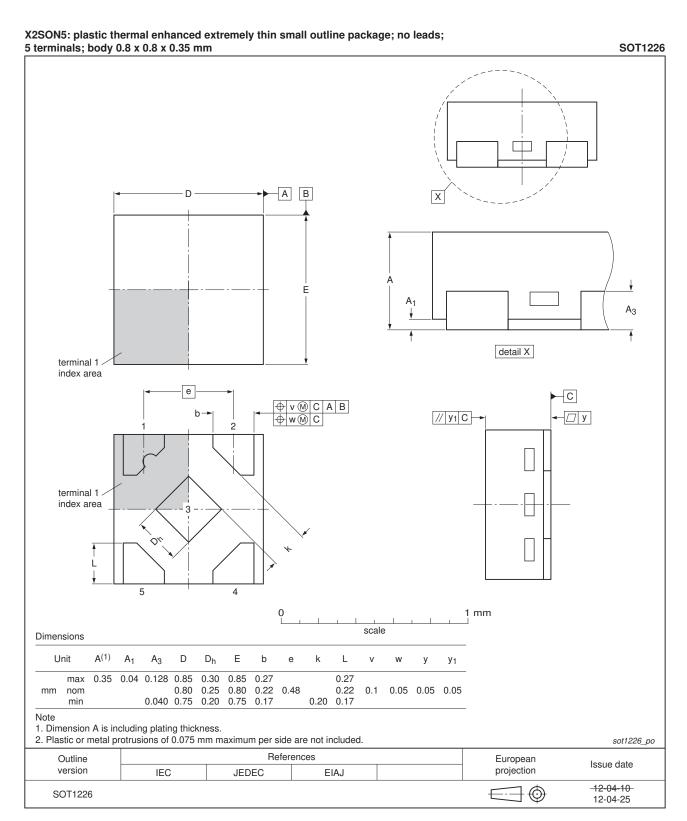


Fig 16. Package outline SOT1226 (X2SON5)

### 14. Abbreviations

#### Table 11. Abbreviations

Acronym	Description
CMOS	Complementary Metal Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
НВМ	Human Body Model
MM	Machine Model
TTL	Transistor-Transistor Logic

## 15. Revision history

#### Table 12. Revision history

Table 121 Hoteler motory						
Document ID	Release date	Data sheet status	Change notice	Supersedes		
74LVC1G34 v.5	20120702	Product data sheet	-	74LVC1G34 v.4		
Modifications:	<ul> <li>Added type n</li> </ul>	umber 74LVC1G34GX (SOT1	226)			
	<ul> <li>Package outl</li> </ul>	ine drawing of SOT886 (Figure	e 12) modified.			
74LVC1G34 v.4	20111206	Product data sheet	-	74LVC1G34 v.3		
Modifications:	Legal pages updated.					
74LVC1G34 v.3	20100902	Product data sheet	-	74LVC1G34 v.2		
74LVC1G34 v.2	20070521	Product data sheet	-	74LVC1G34 v.1		
74LVC1G34 v.1	20050907	Product data sheet	-	-		

### 16. Legal information

#### 16.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <a href="http://www.nxp.com">http://www.nxp.com</a>.

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### 18. Contents

1	General description 1
2	Features and benefits
3	Ordering information 2
4	Marking 2
5	Functional diagram 2
6	Pinning information 3
6.1	Pinning
6.2	Pin description
7	Functional description 4
8	Limiting values 4
9	Recommended operating conditions 4
10	Static characteristics 5
11	Dynamic characteristics
12	Waveforms
13	Package outline 9
14	Abbreviations
15	Revision history
16	Legal information
16.1	Data sheet status
16.2	Definitions
16.3	Disclaimers
16.4	Trademarks18
17	Contact information
18	Contents

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